
Sub-6GHz/mmW共構之 多輸入輸出射頻模組— 射頻傳收機架構

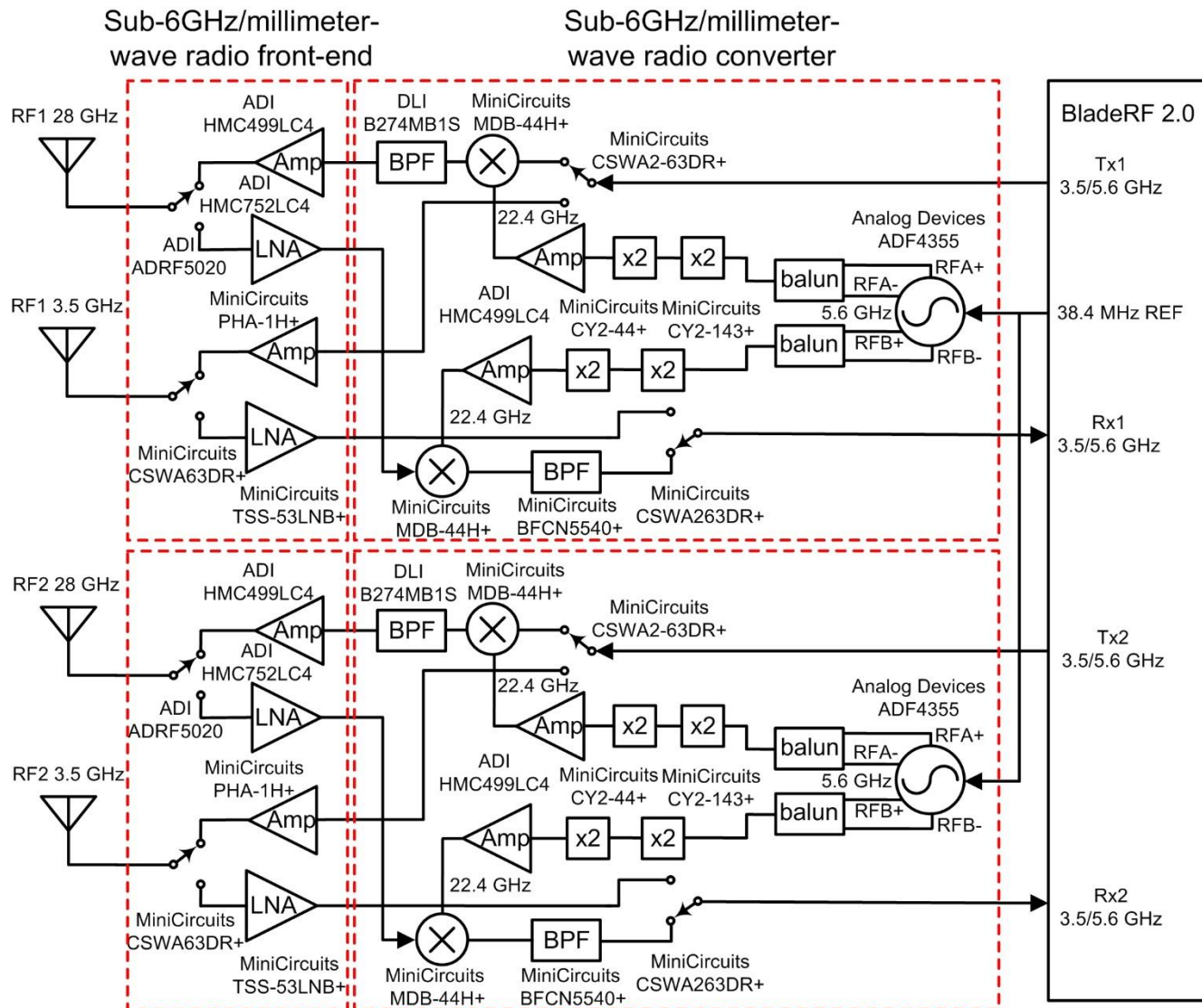
大綱

- Sub-6GHz/mmW共構之多輸入輸出射頻傳收機
 - 設計考量
 - Sub-6GHz軟體無線電平台
 - Sub-6GHz/mmW轉換器模組
 - Sub-6GHz/mmW射頻前端模組
 - 天線模組
- 多輸入輸出射頻傳收機組成元件
 - 頻率合成器
 - 頻率乘法器
 - 升／降頻混頻器
 - 濾波器
 - 低雜音放大器
 - 功率放大器
 - 射頻開關
 - 天線

Sub-6GHz/mmW射頻傳收機架構設計考量

- 需展示sub-6GHz/mmW多輸入輸出功能
- 盡量利用具多輸入輸出之商用軟體無線電平台
- 軟體無線電平台需支援常用之軟體系統
- 具擴充性
- 使用低成本且已封裝完成之微波／毫米波元件
- 除非測試需求，不使用價格高昂的K-type接頭
- 天線採印刷電路板製作之平面式天線
- 印刷電路板利用半導體研究中心提供之製程服務

Sub-6GHz/mmW 2x2射頻傳收機架構圖



Sub-6GHz/mmW 2x2射頻傳收機架構說明

- 射頻傳收架構概分為軟體無線電、射頻轉換器與射頻前端三大區塊
- 利用具2收2發之商用BladeRF-2.0軟體無線電平台
- 以MATLAB做軟體發展平台與介面
- 可展示3.5 GHz或28 GHz之射頻傳收
- 可展示SISO或2x2-MIMO功能
- 所有IC皆為封裝完成之商用產品
- 28 GHz採用平面式八木天線， 3.5 GHz採用微帶天線
- 印刷電路板為半導體研究中心提供之RO4003C/FR4四層板製程服務

Sub-6GHz BladeRF 2.0軟體無線電平台

- ADC/DAC sample rate: 0.521 MSPS – 61.44 MSPS
- ADC/DAC resolution: 12 bits
- VCTCXO calibrated accuracy: 16 ppb
- RF Rx tuning range: 70 MHz – 6 GHz
- RF Rx tuning range: 47 MHz – 6 GHz
- RF bandwidth filter: 0.2 MHz – 56 MHz
- CW output power: 8 dBm
- FPGA logic elements: 49 KLE – 301 KLE
- FPGA memory: 3,383 Kbits – 13,917 Kbits
- Variable-precision DSP blocks: 66 – 342
- Embedded 18x18 multiplier: 132 – 684

Source: <https://www.nuand.com/bladerf-2-0-micro/>

Sub-6GHz/mmW轉換器模組

- 頻率合成器
- 頻率乘法器
- 本地振盪信號放大器
- 升／降頻混頻器
- 帶通濾波器

Sub-6GHz/mmW射頻前端模組

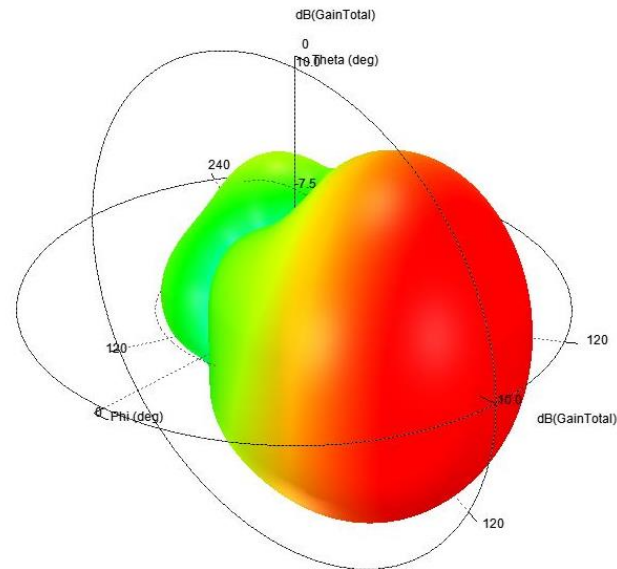
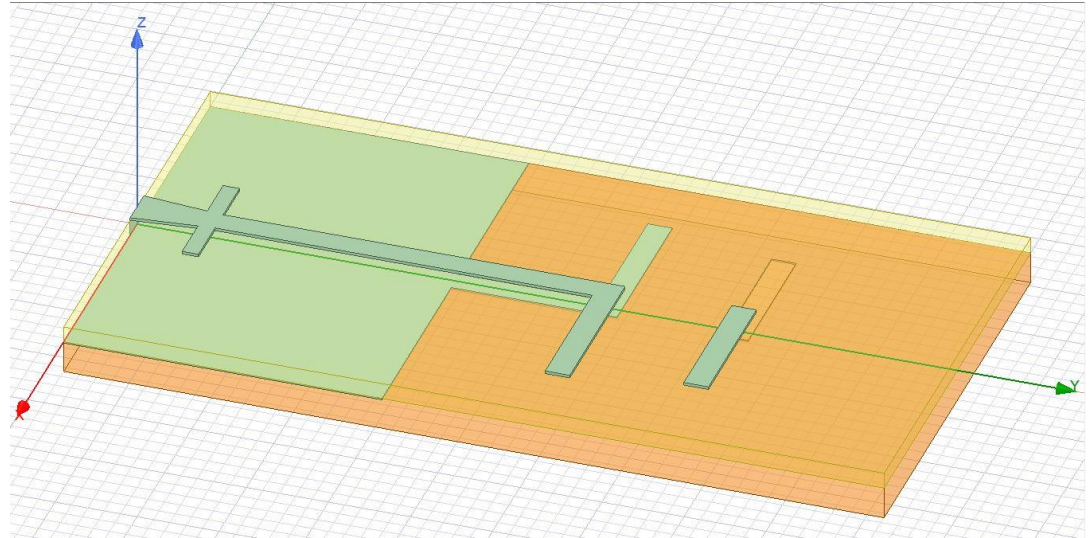
- 低雜音放大器
- 功率放大器
- 射頻開關

天線模組

- 3.5 GHz 1x2 微帶天線陣列
- 28 GHz 1x2 平面式八木天線陣列

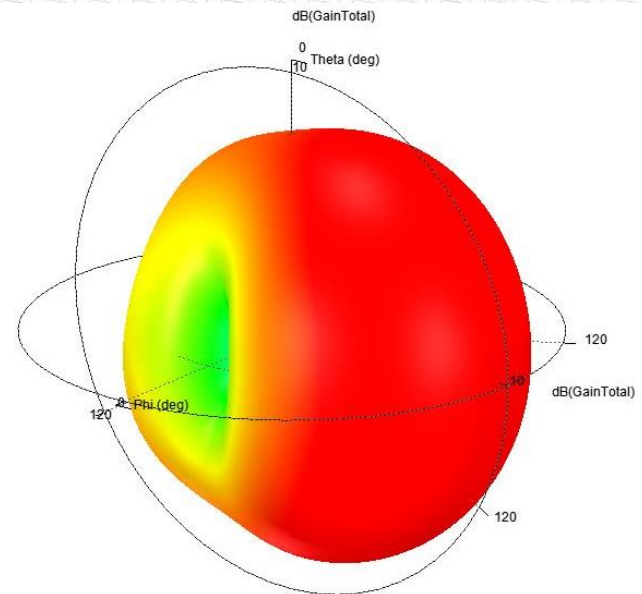
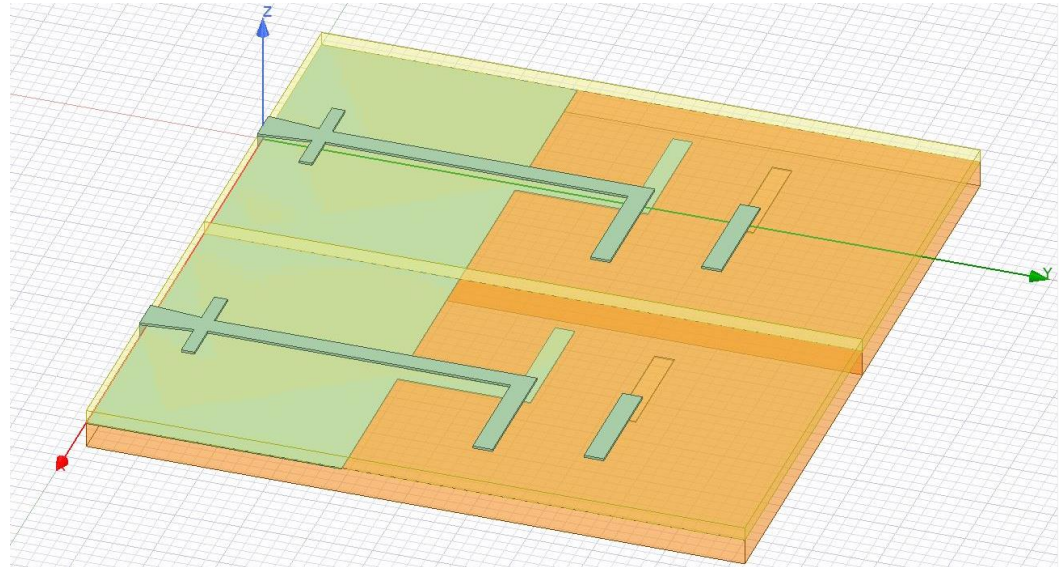
天線模組 - I

- RO4003C/FR4四層板
- 平面式八木天線
- End-fire輻射型式
- 增益7.4 dB
- 反射係數 $< -10\text{dB}$ 頻寬 1 GHz以上
- 面積 $5.36\text{mm} \times 10\text{mm}$



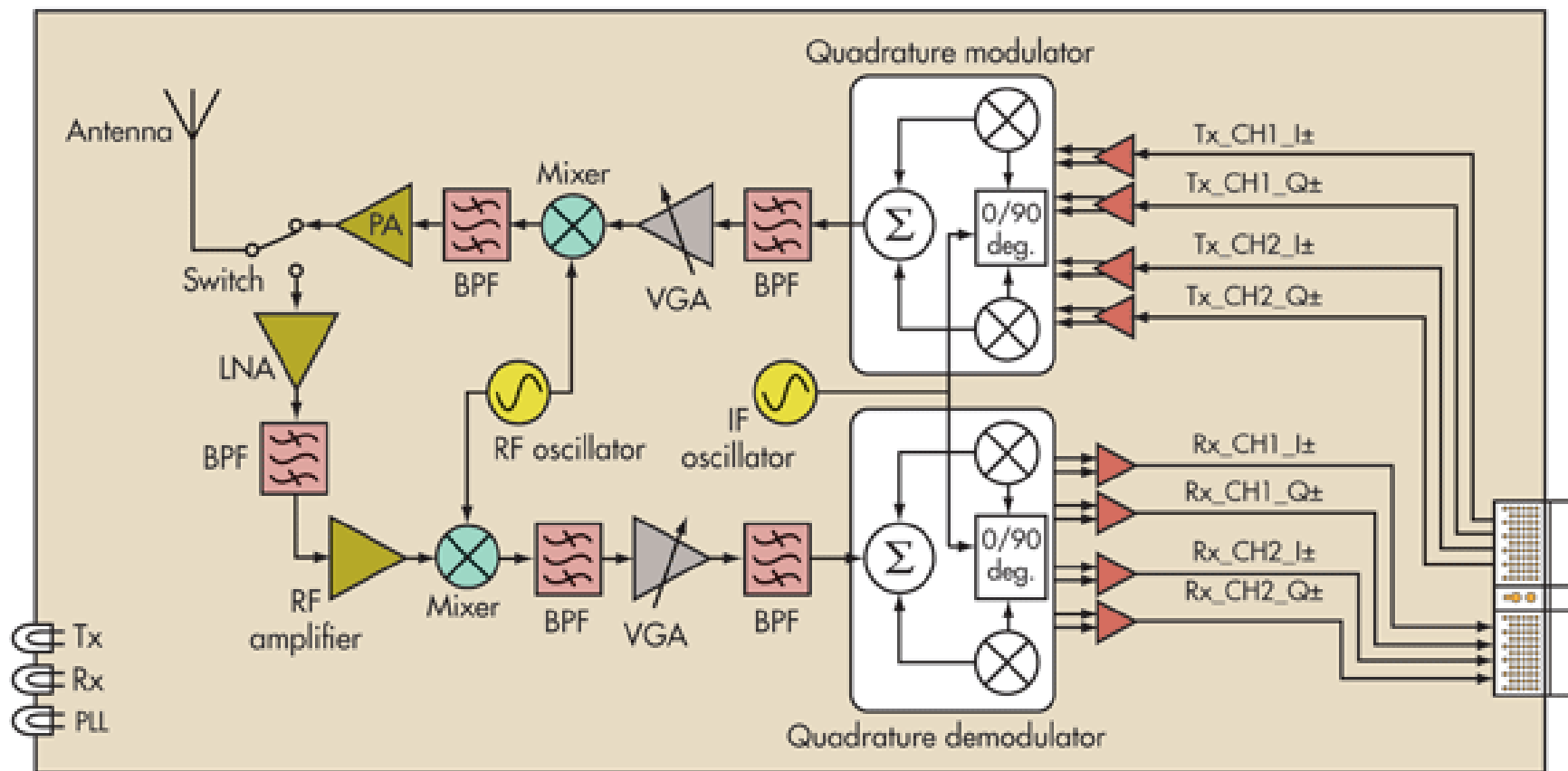
天線模組 - II

- RO4003C/FR4四層板
- 平面式八木天線
- End-fire輻射型式
- 增益8.0 dB
- 反射係數 < -10dB頻寬 1 GHz以上
- 面積10.72mm x 10mm



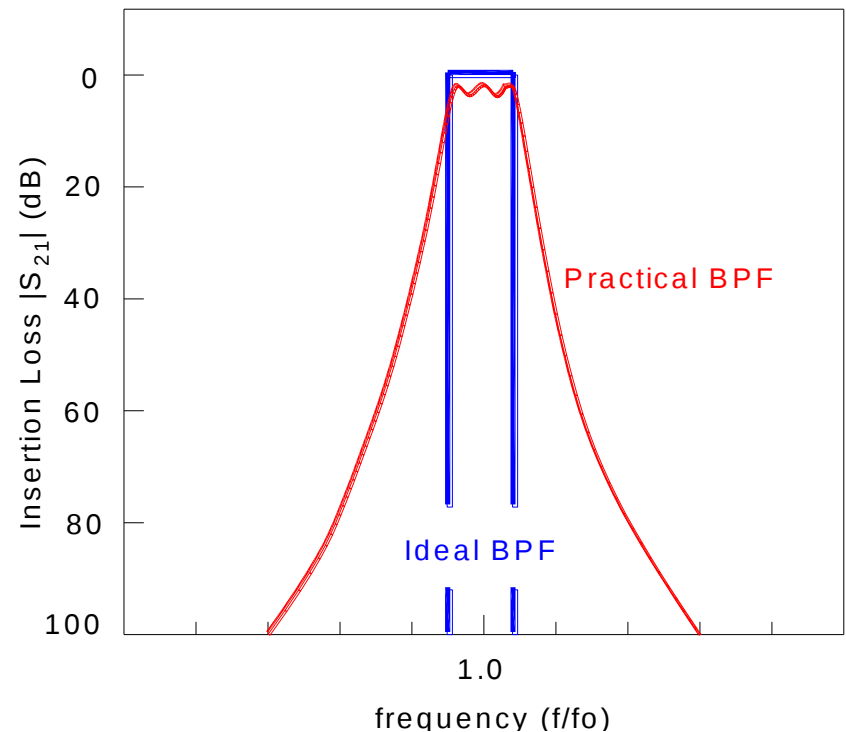
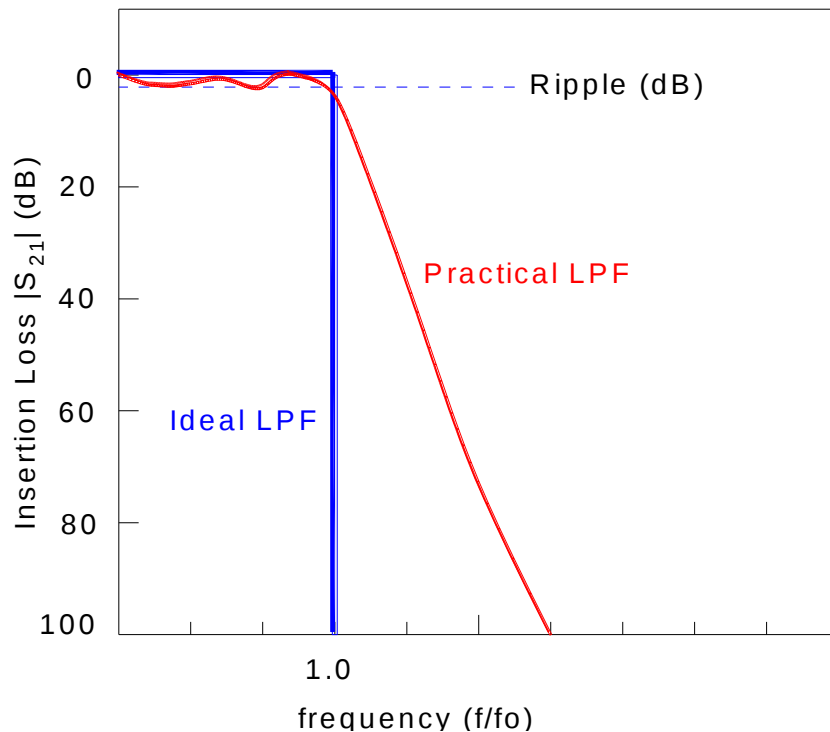
Sub-6GHz/mmW共構之 多輸入輸出射頻模組－ 射頻傳收機電路模組 分析、設計與量測

The role of RF filters



Microwave filters

- Filter types: Low-pass, High-pass, Band-pass, Band-reject, All-pass, ...



Design methods

(1) Image Parameter Method

- A cascade of simple two-port filter sections to provide the desired cutoff
- frequencies and attenuation characteristics, but not allow the spec of a frequency response over the complete operating range.

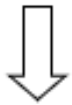
(2) Insertion Loss Method

- Network synthesis technique to complete the whole frequency response.

Design Procedure

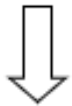
Filter Specification

N (order), f_o , Δf , or $\Delta f/f_o$ (fractional bandwidth), Ripple (dB), minimal attenuation at f_1/f_o , ..., etc.



Low-pass Prototype

A prescribed filter function with Z_o normalized to 1 Ω , and ω normalized to 1 rad./sec. Order N , Δ , and ripple level are required.



Scaling Conversion

Frequency and impedance scaling are required for transforming the prototype function to the desired filter function.

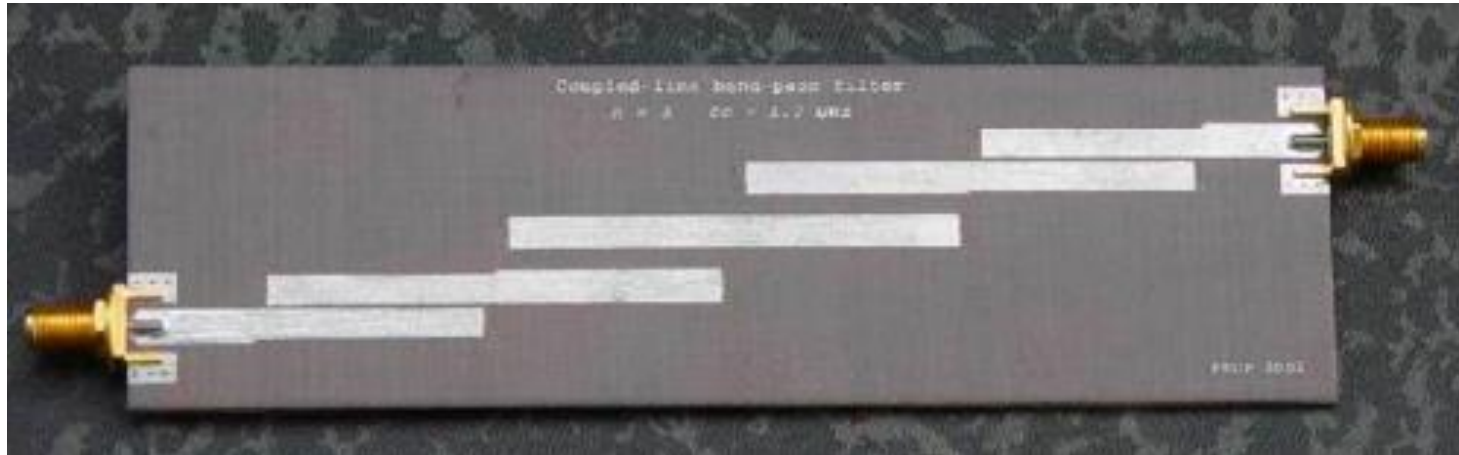


Implementation

Filters of Microstrip, CPW, Lumped elements and Rectangular waveguide are implemented in different ways. Their theories are the same.



Coupled line filters



Design formulas for a coupled-line filter

Once J_1 , J_2 , and J_3 are found, then Z_{0e} and Z_{0o} can be determined via

$$\begin{cases} Z_{0e} = Z_0 [1 + JZ_0 + (JZ_0)^2] \\ Z_{0o} = Z_0 [1 - JZ_0 + (JZ_0)^2] \end{cases}$$

For any N and arbitrary Z_L ($Z_L = Z_0$ ($g_{N+1} = 1$)
or $Z_L \neq Z_0$ ($g_{N+1} \neq 1$)),

Design data:

StripLine: $\underline{w_n/d}$ and $\underline{s_n/d}$

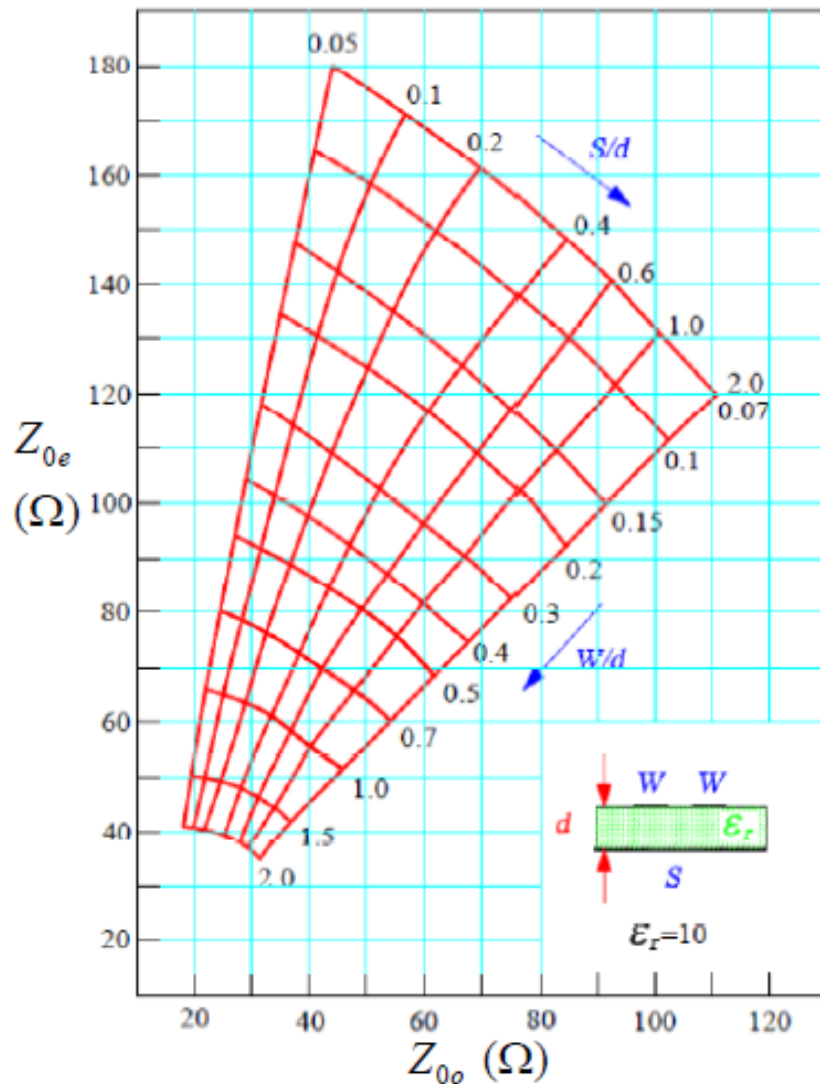
Microstrip: $\underline{w_n/d}$ and $\underline{s_n/d}$

$$Z_0 J_1 = \sqrt{\frac{\pi \Delta}{2 g_1}}$$

$$Z_0 J_n = \frac{\pi \Delta}{2 \sqrt{g_{n-1} g_n}}, \quad n = 2, 3, \dots, N$$

$$Z_0 J_{N+1} = \sqrt{\frac{\pi \Delta}{2 g_N g_{N+1}}}$$

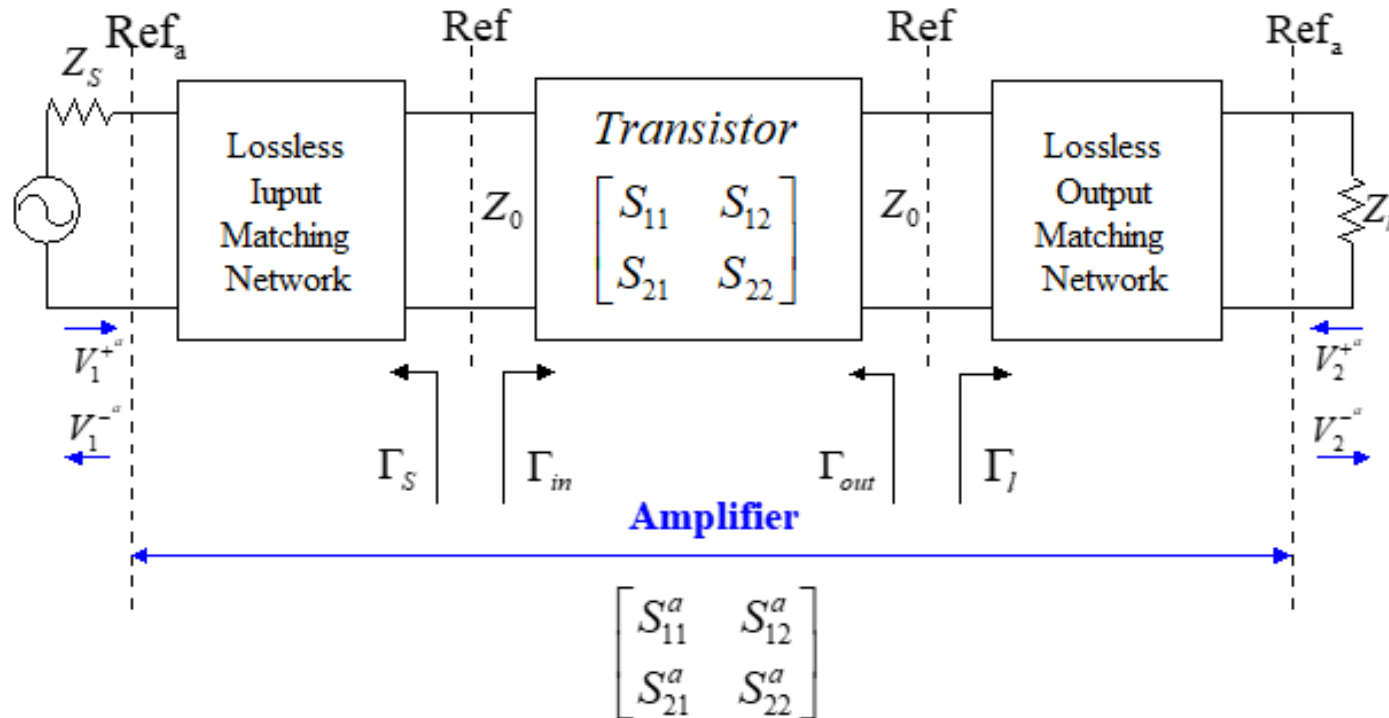
Z_{0e} and Z_{0o} Design Data for a Microstrip



- (1) **Quasi-static** results, realistic microstrip is dispersive. Usable up to 5–6 GHz.
- (2) If ϵ_r is different or frequency is sufficiently high, the data must be changed.
- (3) Given Z_{0e} and Z_{0o} , s/d and w/d are **uniquely specified**.
- (4) Phase velocity data is not shown.



Microwave Amplifier Gain



$$P_{avs} = \frac{|V_1^{+a}|^2}{2Z_0}, \quad P_l = \frac{|V_2^{-a}|^2}{2Z_0} \Rightarrow |S_{21}^a|^2 = \frac{|V_2^{-a}|^2}{|V_1^{+a}|^2} \Big|_{V_2^{+a}=0} = \frac{P_l}{P_{avs}} = G_T = \frac{|S_{21}|^2(1-|\Gamma_S|^2)(1-|\Gamma_l|^2)}{|1-S_{22}\Gamma_l|^2|1-\Gamma_S\Gamma_{in}|^2}$$

◆ For lossless input and output matching networks, the amplifier gain $|S_{21}^a|^2$ is equal to the transistor transducer gain (G_T).



Other Power Gain

$$G_T(\Gamma_S, \Gamma_L) = \frac{|S_{21}|^2 (1 - |\Gamma_S|^2)(1 - |\Gamma_L|^2)}{|1 - S_{22}\Gamma_L|^2 |1 - \Gamma_S\Gamma_{in}|^2} = \frac{(1 - |\Gamma_S|^2)|S_{21}|^2(1 - |\Gamma_L|^2)}{|(1 - S_{11}\Gamma_S)(1 - S_{22}\Gamma_L) - S_{12}S_{21}\Gamma_S\Gamma_L|^2}$$

$G_{TU}(\Gamma_S, \Gamma_L)$ = Unilateral transducer power gain

$$= G_T(\Gamma_S, \Gamma_L) \Big|_{S_{12}=0} = \frac{(1 - |\Gamma_S|^2)}{|1 - S_{11}\Gamma_S|^2} |S_{21}|^2 \frac{(1 - |\Gamma_L|^2)}{|1 - S_{22}\Gamma_S|^2}$$

$G_P(\Gamma_L)$ = Operating power gain

$$= G_T(\Gamma_S = \Gamma_{in}^*, \Gamma_L) = \frac{|S_{21}|^2 (1 - |\Gamma_L|^2)}{(1 - |\Gamma_{in}|^2) |1 - S_{22}\Gamma_L|^2}$$

$G_A(\Gamma_S)$ = Available power gain

$$= G_T(\Gamma_S, \Gamma_L = \Gamma_{out}^*) = \frac{|S_{21}|^2 (1 - |\Gamma_S|^2)}{(1 - |\Gamma_{out}|^2) |1 - S_{11}\Gamma_S|^2}$$



$G_{\max}$ = Maximum available power gain

$$= G_T (\Gamma_S = \Gamma_{in}^*, \Gamma_L = \Gamma_{out}^*) = \frac{|S_{21}|}{|S_{12}|} \left(k - \sqrt{k^2 - 1} \right), \quad k \text{ is stability factor}$$

$G_{TU \max}$ = Maximum unilateral power gain

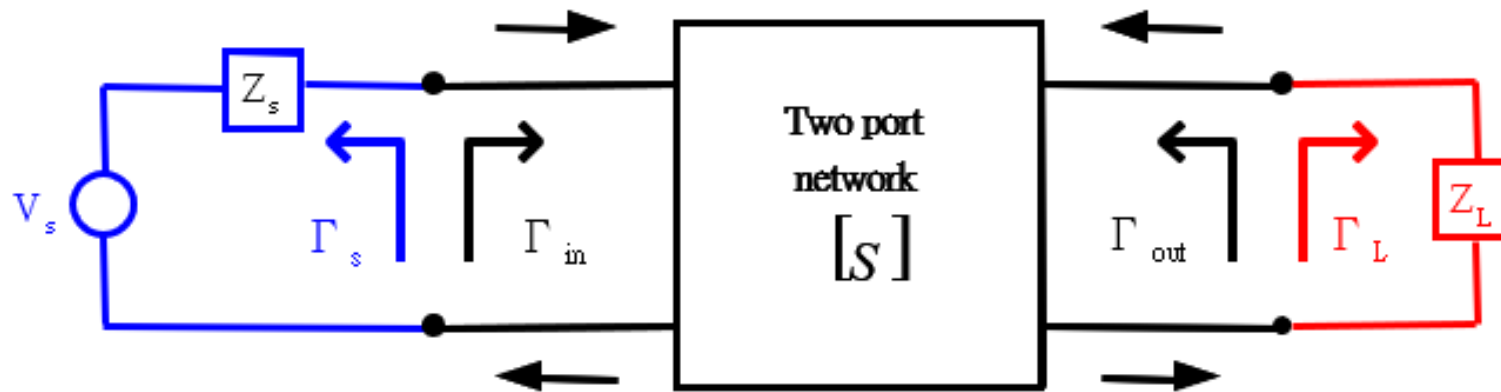
$$= G_{TU} (\Gamma_S = \Gamma_{in}^*, \Gamma_L = \Gamma_{out}^*) = \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$$

G_{ms} = Maximum stable power gain

$$= G_{\max} \Big|_{k=1} = \frac{|S_{21}|}{|S_{12}|}$$

- In general, the amplifier gain will be larger than the transistor gain due to the impedance matching of the transistor at both input and output.

Stability Condition



Unconditional stable:

$$\forall \Gamma_s, \Gamma_L \rightarrow$$

$$|\Gamma_{in}| = \left| S_{11} + \frac{S_{21}\Gamma_L S_{12}}{1 - S_{22}\Gamma_L} \right| < 1$$

$$|\Gamma_{out}| = \left| S_{22} + \frac{S_{21}\Gamma_L S_{12}}{1 - S_{11}\Gamma_s} \right| < 1$$

Conditional stable:

$$\exists \Gamma_s, \Gamma_L \rightarrow$$

$$|\Gamma_{in}| = \left| S_{11} + \frac{S_{21}\Gamma_L S_{12}}{1 - S_{22}\Gamma_L} \right| > 1$$

$$|\Gamma_{out}| = \left| S_{22} + \frac{S_{21}\Gamma_L S_{12}}{1 - S_{11}\Gamma_s} \right| > 1$$



Determine Unconditional stability by mathematical equations

- Rollet's condition (k- Δ test) for unconditional stability.

$$k = \frac{1 - |S_{11}|^2 - |S_{22}|^2 + |\Delta|^2}{2|S_{12}S_{21}|} > 1$$

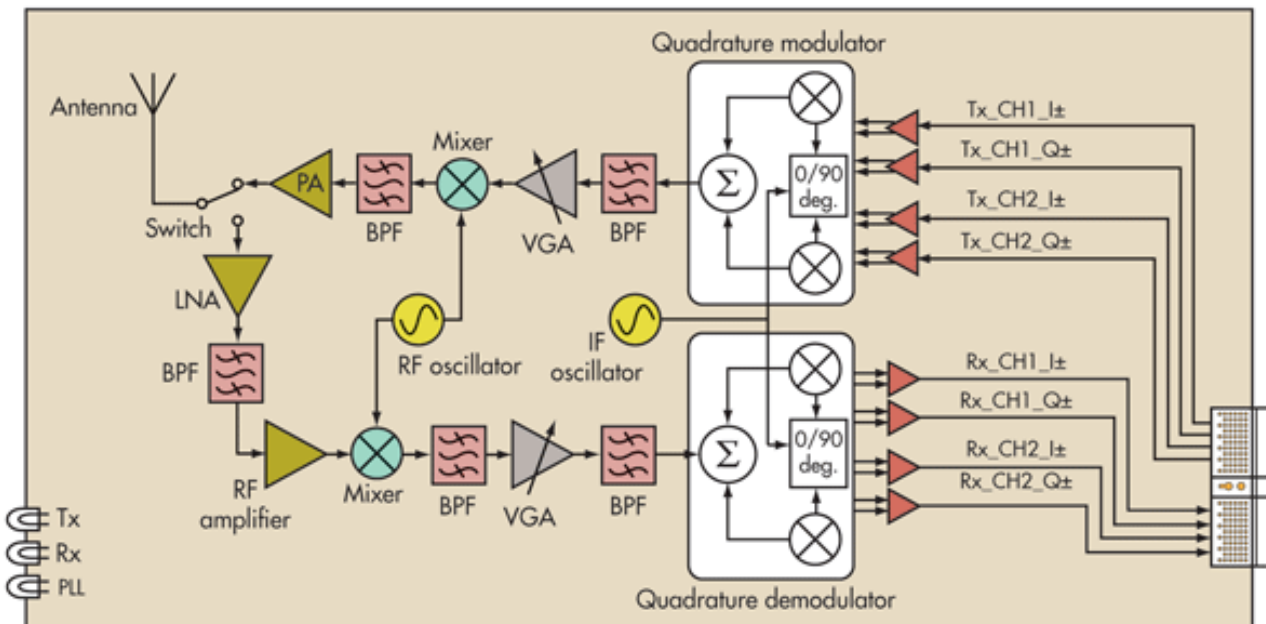
$$|\Delta| = |S_{11}S_{22} - S_{12}S_{21}| < 1$$

- In 1992, Edwards et. al. derived a new criterion that combines the k- Δ parameters into a test involving only a single parameter μ for unconditional stability. Thus, if $\mu > 1$, the device is unconditional stable. In addition, it can be said that large values of μ imply greater stability.

$$\mu = \frac{1 - |S_{11}|^2}{|S_{22} - \Delta S_{11}^*| + |S_{12}S_{21}|} > 1$$

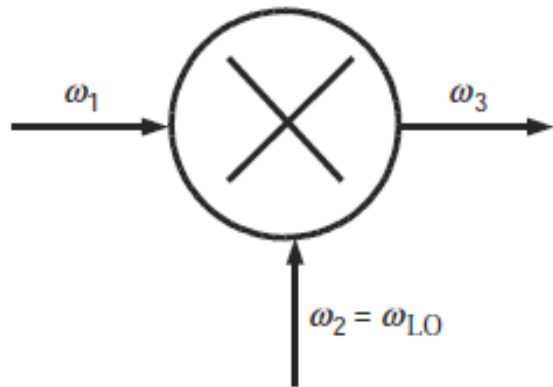
The role of Mixers

- Mixers perform frequency translation by multiplying two waveforms (and possibly their harmonics).
- Three-port circuit requiring an LO reference input
 - Down-conversion in receivers, output frequency (IF) is the difference of two input frequencies (RF and LO)
 - Up-conversion in transmitters, output frequency (RF) is the sum of two input frequencies (IF and LO).



Basic operation (I)

- The ideal behavior of the mixer as a multiplier.
- Signals are produced at the output at the sum and difference frequencies of the two inputs.
- In practice, the multiplier is implemented with a **non-linear element** such as a diode or transistor, or with a **time-varying element**.

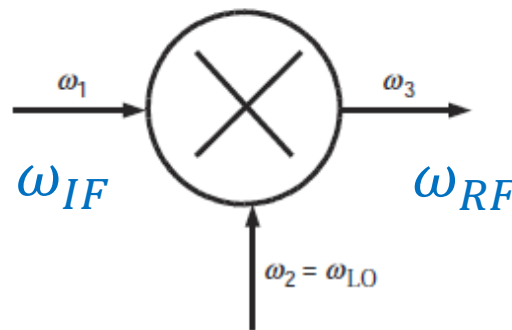


$$A \cos(\omega_1 t) \times B \cos(\omega_2 t) \\ = \frac{AB}{2} [\cos(\omega_1 - \omega_2)t + \cos(\omega_1 + \omega_2)t]$$

Basic operation (II)

- **Upconverter mixer operation**

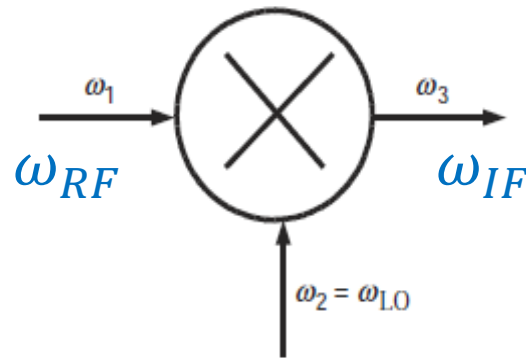
- the mixer input signal is applied at the IF port $\omega_1 = \omega_{IF}$, $\omega_2 = \omega_{LO}$ and both the $\omega_{LO} - \omega_{IF} = \omega_{RF}$ and the $\omega_{LO} + \omega_{IF} = \omega_{RF}$ sidebands are generated at the RF (output) port.
- The sum frequency $\omega_{RF} = \omega_{LO} + \omega_{IF}$ is known as the upper sideband (USB). The mixer also produces a lower sideband (LSB) at $\omega_{RF} = \omega_{LO} - \omega_{IF}$.
- A bandpass filter, placed at the RF port, selects the desired signal ($\omega_{RF} = \omega_{LO} + \omega_{IF}$) and rejects any leakage from the IF and LO ports.



Basic operation (II)

- **Downconverter mixer operation**

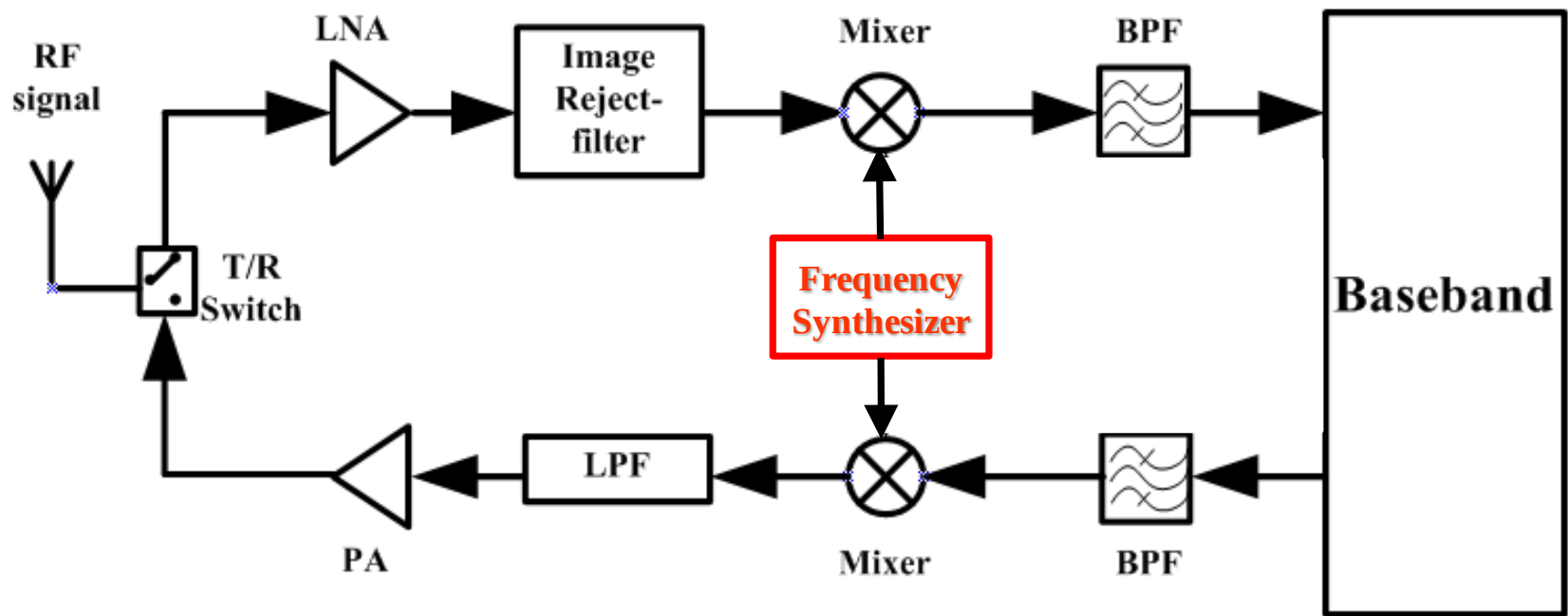
- In a receiver, the input signal is applied to the RF port and $\omega_1 = \omega_{RF}$, where $\omega_{RF} = \omega_{LO} + \omega_{IF}$ or $\omega_{RF} = \omega_{LO} - \omega_{IF}$.
- The LO signal is applied at port 2, as in an upconverter, $\omega_2 = \omega_{LO}$, and signals both at $\omega_{RF} - \omega_{LO} = \omega_{IF}$ and $\omega_{LO} - \omega_{RF} = \omega_{IF}$ are collected at the IF port.



General Considerations

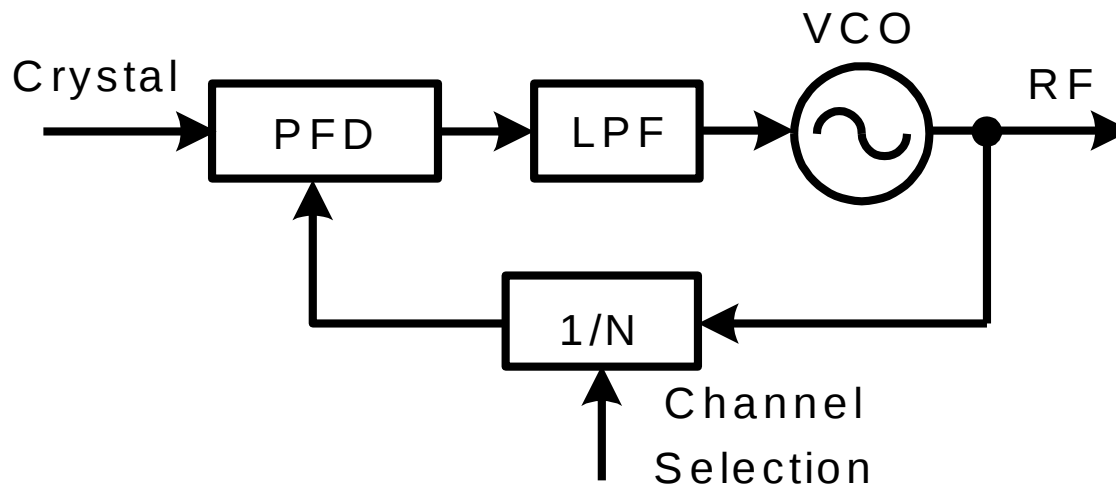
- Impedance matching
- Conversion gain
- Noise performance
- Isolation
- Linearity
- Spurious

Frequency Synthesizer in Wireless System

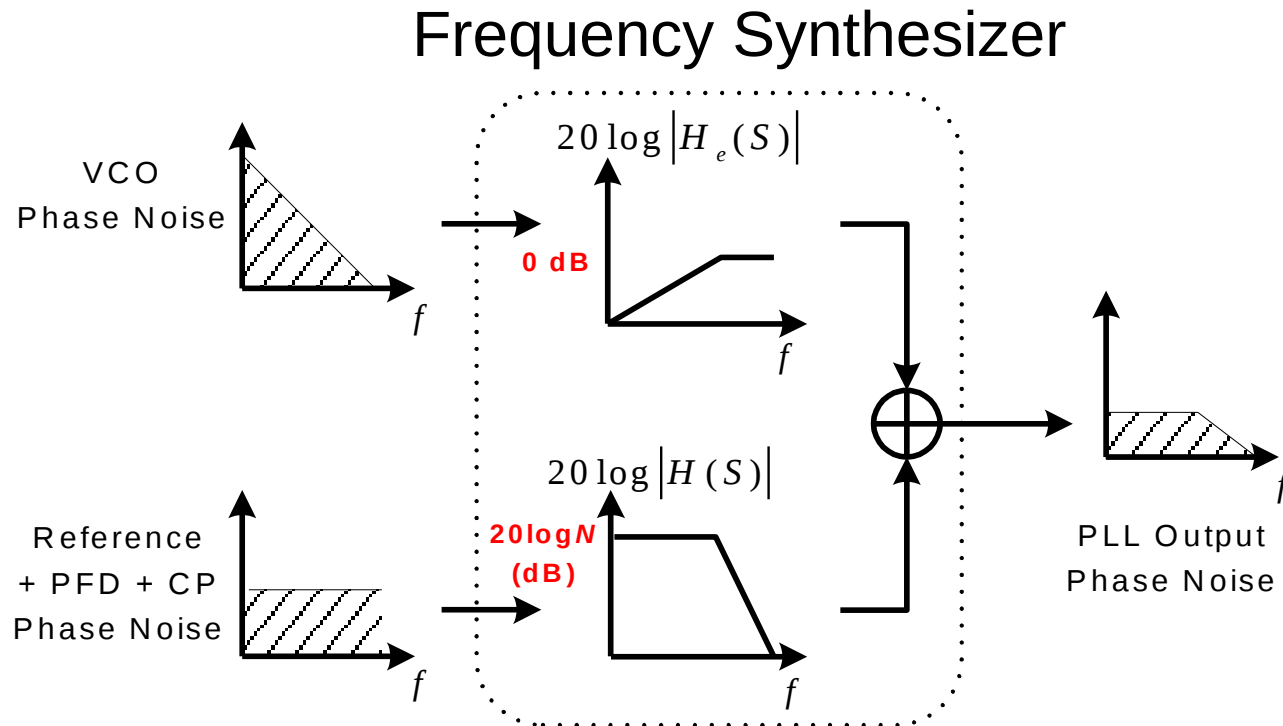


PLL-based Frequency Synthesizer

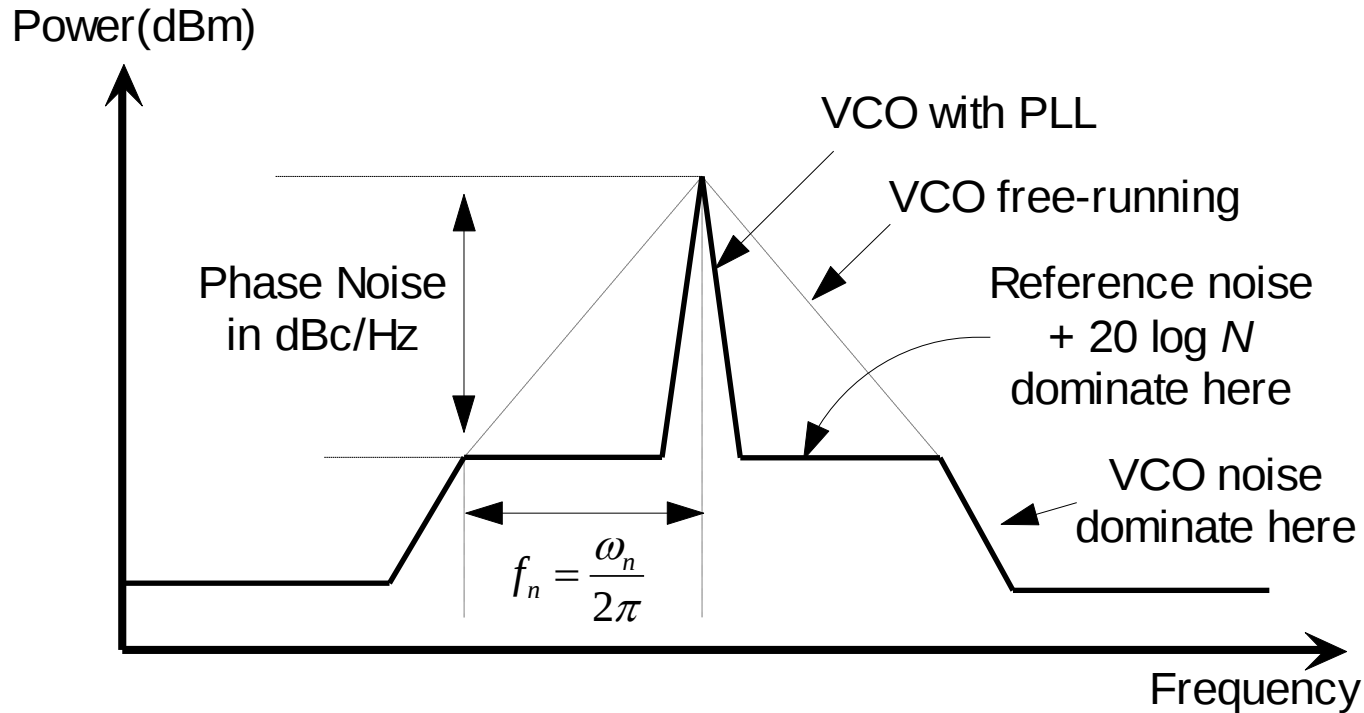
- Most frequency synthesizers are based on a phase-locked loop (PLL).
- The frequency and phase of the voltage-controlled oscillator (VCO) is locked by the PLL with reference to the crystal oscillator.
- The synthesized frequency can be adjusted by tuning the division value N .



Phase Noise Suppression



Phase Noise Properties and Measurement



$$\mathcal{L}(\Delta f) = 10 \log \left(\frac{P_{sideband} @ \Delta f}{P_{carrier}} \frac{1}{RBW} \right) = 10 \log P_{sideband} @ \Delta f - 10 \log P_{carrier} - 10 \log RBW \text{ (dBc/Hz)}$$

RBW: the resolution BW of spectrum analyzer as measuring phase noise.

Fractional-N

Integer-N

$$f_{VCO} = N \times f_{ref}$$

$$f_{res} = \left[(N + 1) - N \right] f_{ref}$$

$$= f_{ref} = \frac{f_{VCO}}{N}$$

Fractional-N

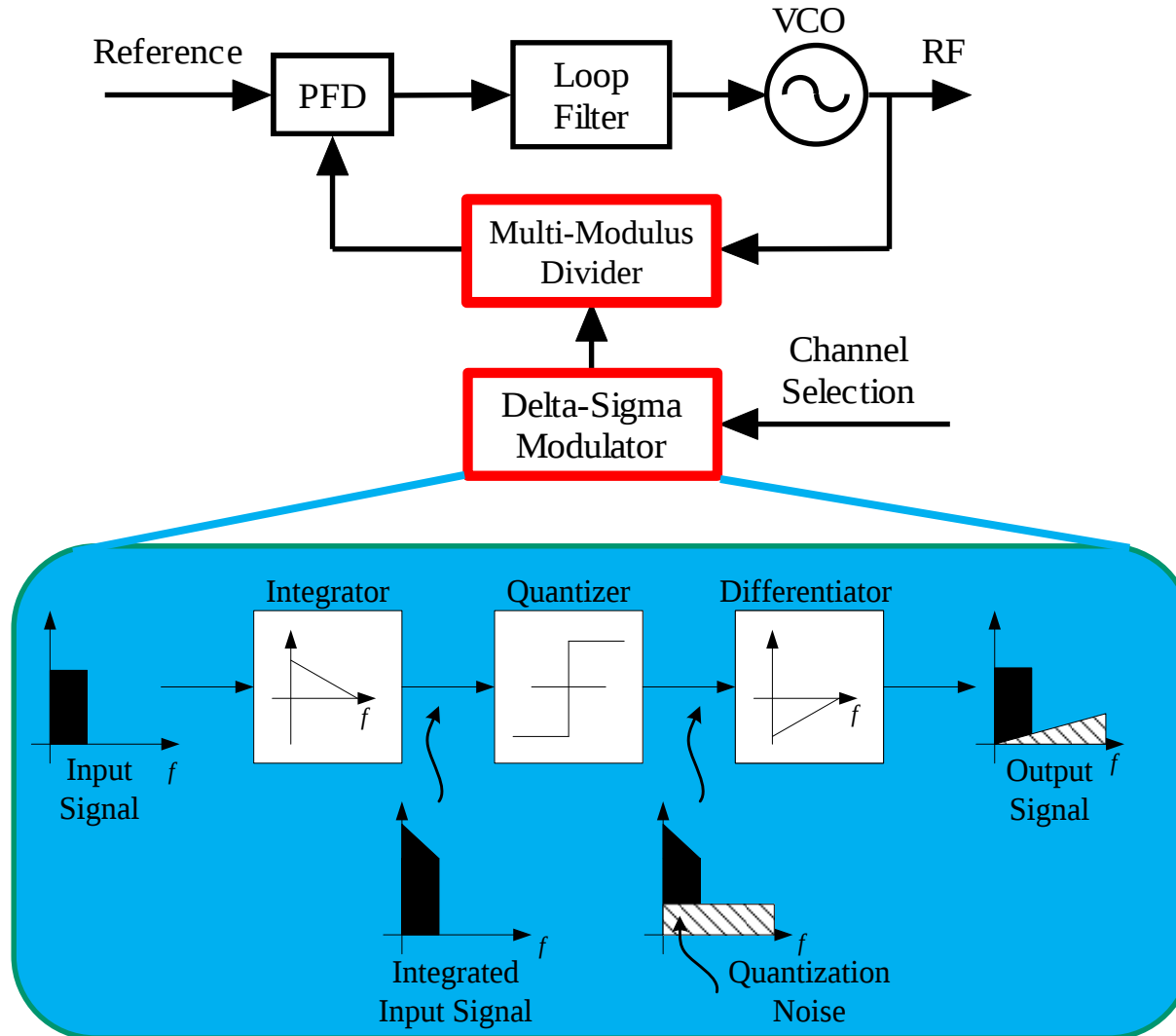
$$f_{VCO} = N \times f_{ref} = \left(P + \frac{A}{M} \right) \times f_{ref}$$

$$f_{res} = \left[\left(P + \frac{A+1}{M} \right) - \left(P + \frac{A}{M} \right) \right] f_{ref}$$

$$= \frac{f_{ref}}{M} = \frac{f_{VCO}}{M \cdot N}$$

The frequency resolution can be arbitrarily modified with M .

Fractional-N Frequency Synthesizer



Sub-6GHz/mmW共構之 多輸入輸出射頻模組— 系統效能分析與評估

大綱

- Sub-6GHz/mmW共構之射頻接收機系統效能分析
- Sub-6GHz/mmW共構之射頻發射機系統效能分析
- Sub-6GHz/mmW共構之多輸入輸出天線系統效能分析
- Sub-6GHz/mmW共構之多輸入輸出射頻傳收機系統效能分析

射頻接收機系統效能

- 接收機鏈路增益
- 接收機雜音指數與接收靈敏度
- 接收機輸入三階折斷點與輸入信號動態範圍
- 接收機影像拒斥比（超外差式接收機）

線性系統雜訊指數

$$S_o = G \cdot S_i \quad N_i = kT_0 B$$

$$N_o = GkT_0 B + GkT_e B; \quad T_e : \text{equivalent noise temperature of the system}$$

$$NR \text{ (noise ratio)} \equiv \frac{(S/N)_i}{(S/N)_o} = \frac{S_i}{S_o} \cdot \frac{N_o}{N_i} = \frac{1}{G} \frac{GkT_0 B + GkT_e B}{kT_0 B} = 1 + \frac{T_e}{T_0}$$



• 三級串接線性系統雜訊比

$$S_o = G_1 G_2 G_3 \cdot S_i \quad N_i = kT_0 B$$

$$\begin{aligned} N_o &= G_1 G_2 G_3 kT_0 B + G_1 G_2 G_3 kT_{e1} B + G_2 G_3 kT_{e2} B + G_3 kT_{e3} B \\ &= G_1 G_2 G_3 N_i + G_1 G_2 G_3 (NR_1 - 1) N_i + G_2 G_3 (NR_2 - 1) N_i + G_3 (NR_3 - 1) N_i \\ &= G_1 G_2 G_3 NR_1 N_i + G_2 G_3 (NR_2 - 1) N_i + G_3 (NR_3 - 1) N_i \end{aligned}$$

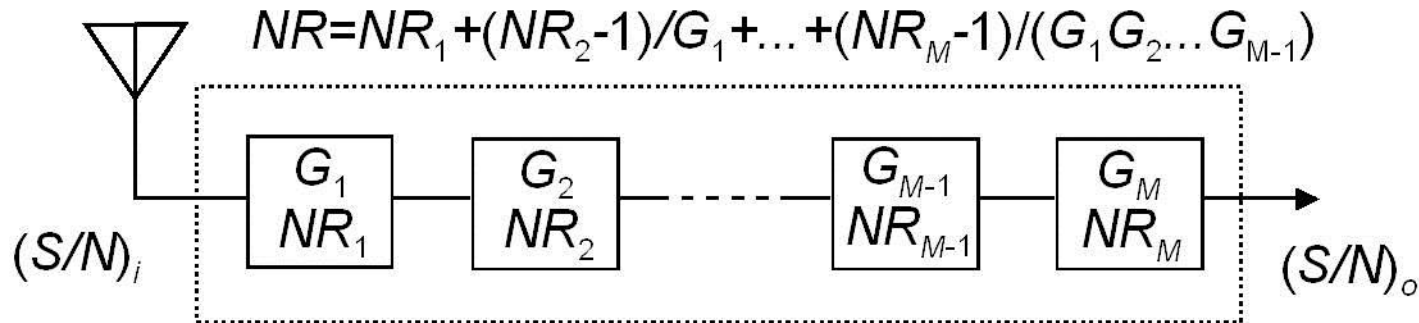
$$NR_{total} = \frac{(S/N)_i}{(S/N)_o} = \frac{S_i}{S_o} \cdot \frac{N_o}{N_i} = \frac{1}{G_1 G_2 G_3} \frac{N_o}{N_i} = NR_1 + \frac{NR_2 - 1}{G_1} + \frac{NR_3 - 1}{G_1 G_2}$$

• M級串接線性系統雜訊指數

$$NR = NR_1 + \frac{NR_2 - 1}{G_1} + \dots + \frac{NR_M - 1}{G_1 G_2 \cdots G_{M-1}}$$

$$NF \text{ (noise figure)} = 10 \log_{10} NR$$

射頻接收系統雜訊指數與靈敏度



- 射頻接收系統輸出端之訊雜比 $(S/N)_o$ 由整體雜訊比 NR 與輸入端之訊雜比 $(S/N)_i$ 決定
- 解調器需有最低的訊雜比確保其誤碼率可保持在一定品質以上，由此可訂出此射頻接收系統之靈敏度（Sensitivity）

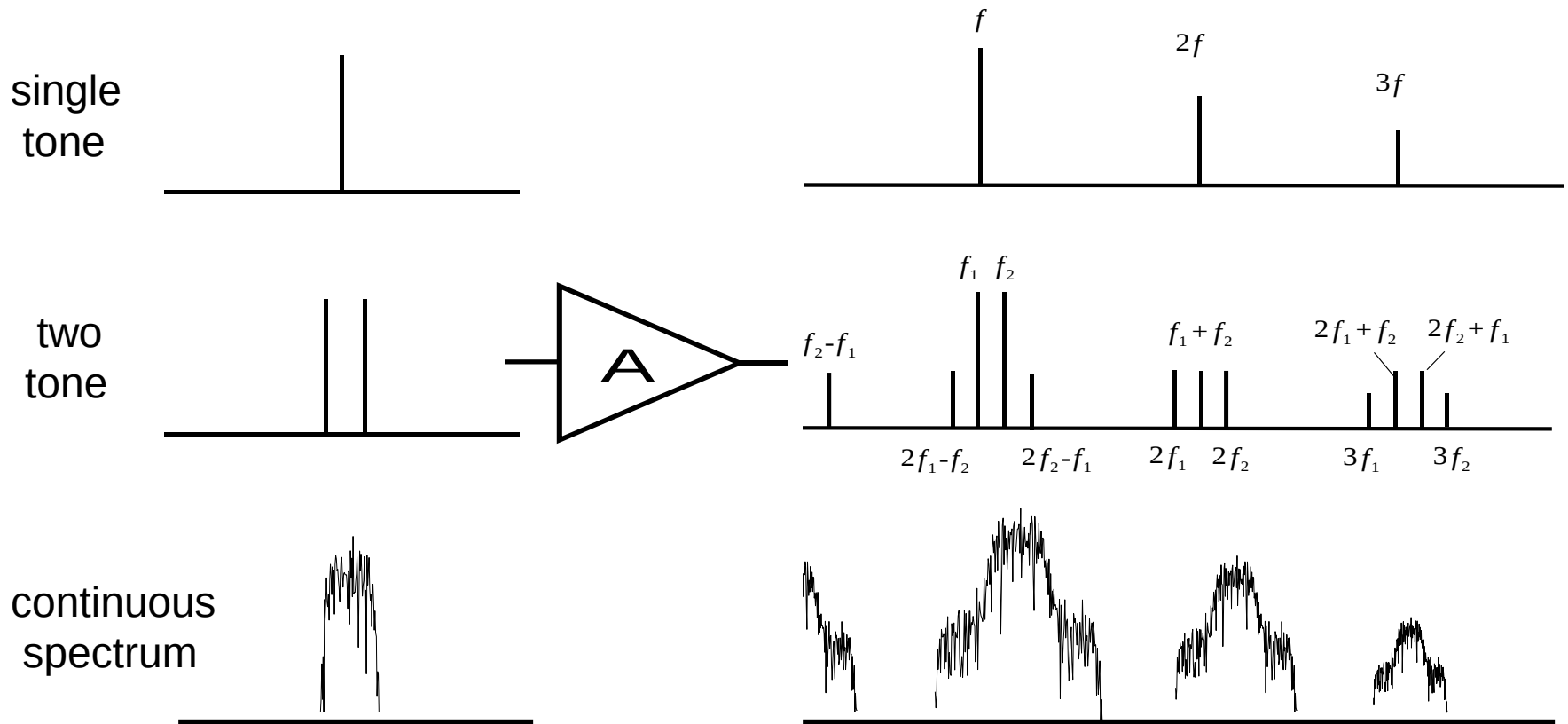
$$S_i = NR \cdot (S/N)_{o,\min} \cdot N_i, \quad N_i = kTB$$

$$S_{i,dBm} = NF + (S/N)_{o,\min,dB} + 10 \log_{10} B - 174 \quad \Big|_{T=290^\circ K}$$

- 射頻接收機第一級電路之雜訊指數具決定性影響

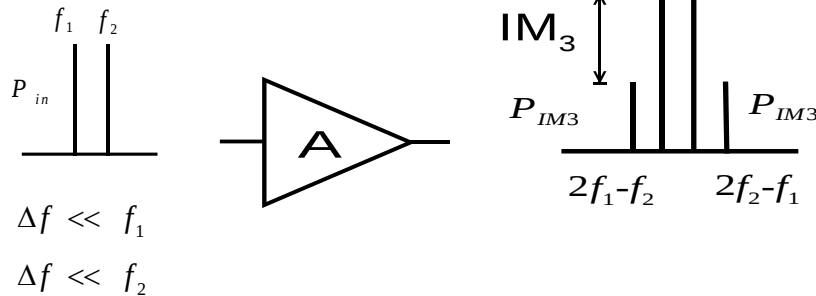
非線性失真

- The nonlinear effects yield signal impairments, including harmonic generation, intermodulation, and spectral regrowth.



三階交互調變失真與動態範圍

dB scale P_{o1}



$$(IP_{3,o} - P_{IM,3}) / 3 = IP_{3,o} - P_{o,1} \text{ (in dBm)}$$

$$2P_{o,1} + \underbrace{(P_{o,1} - P_{IM,3})}_{IM_3 \text{ (dBc)}} = 2IP_{3,o}$$

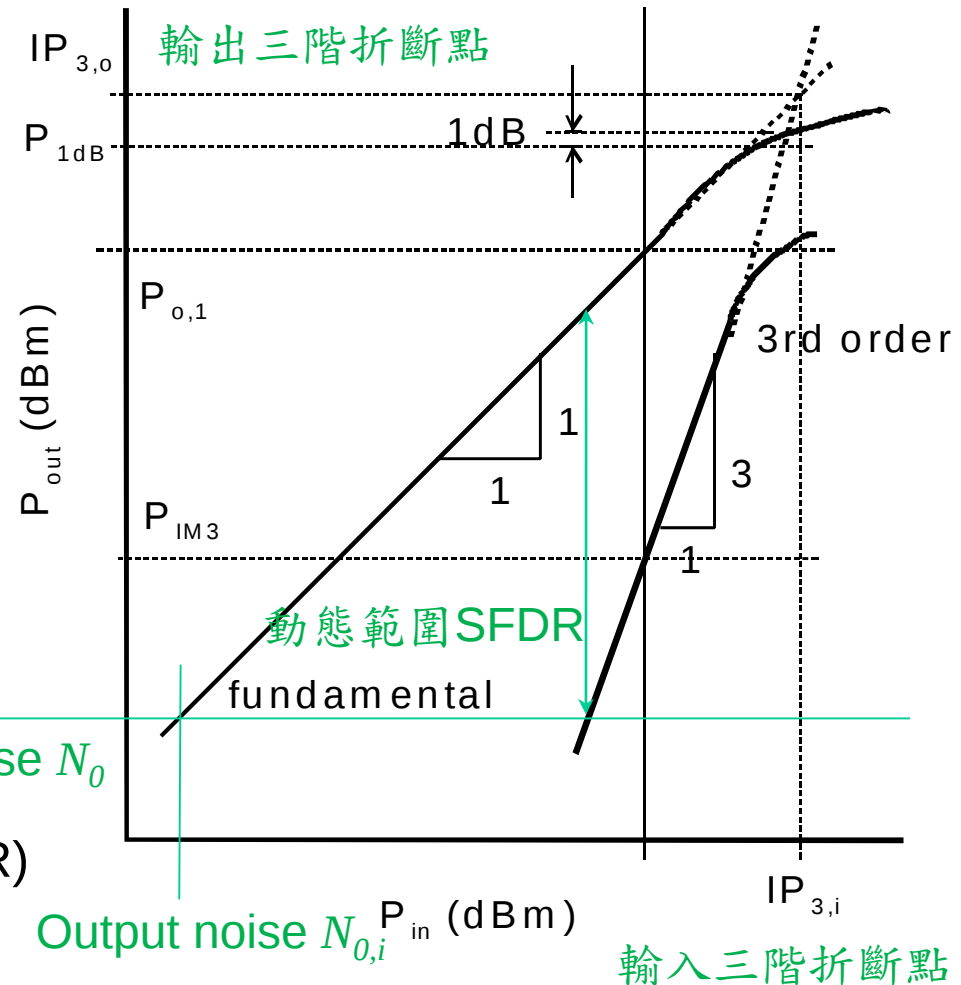
$$\Rightarrow IP_{3,o} = \underbrace{P_{o,1}}_{G + P_{in}} + 0.5 \underbrace{IM_3}_3 \text{ specified by designer}$$

$$\text{or } P_{IM_3} = 3P_{o,1} - 2IP_{3,o}$$

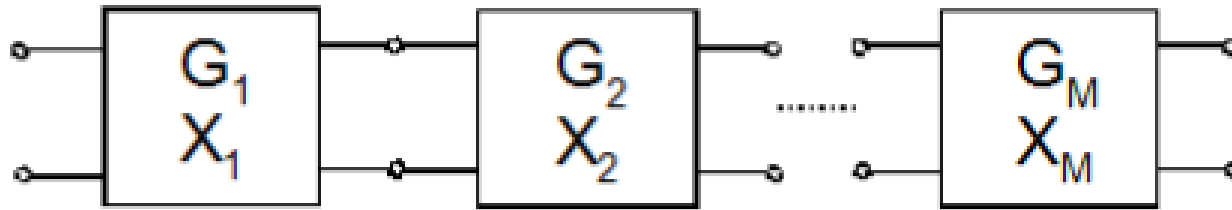
Output noise N_0

Spurious Free Dynamic Range (SFDR)

$$SFDR = \frac{2}{3} [IP_{3,o} - N_0] = \frac{2}{3} [IP_{3,i} - N_{0,i}]$$



射頻接收系統三階折斷點



G_n : gain

X_n : I/P or O/P IP3

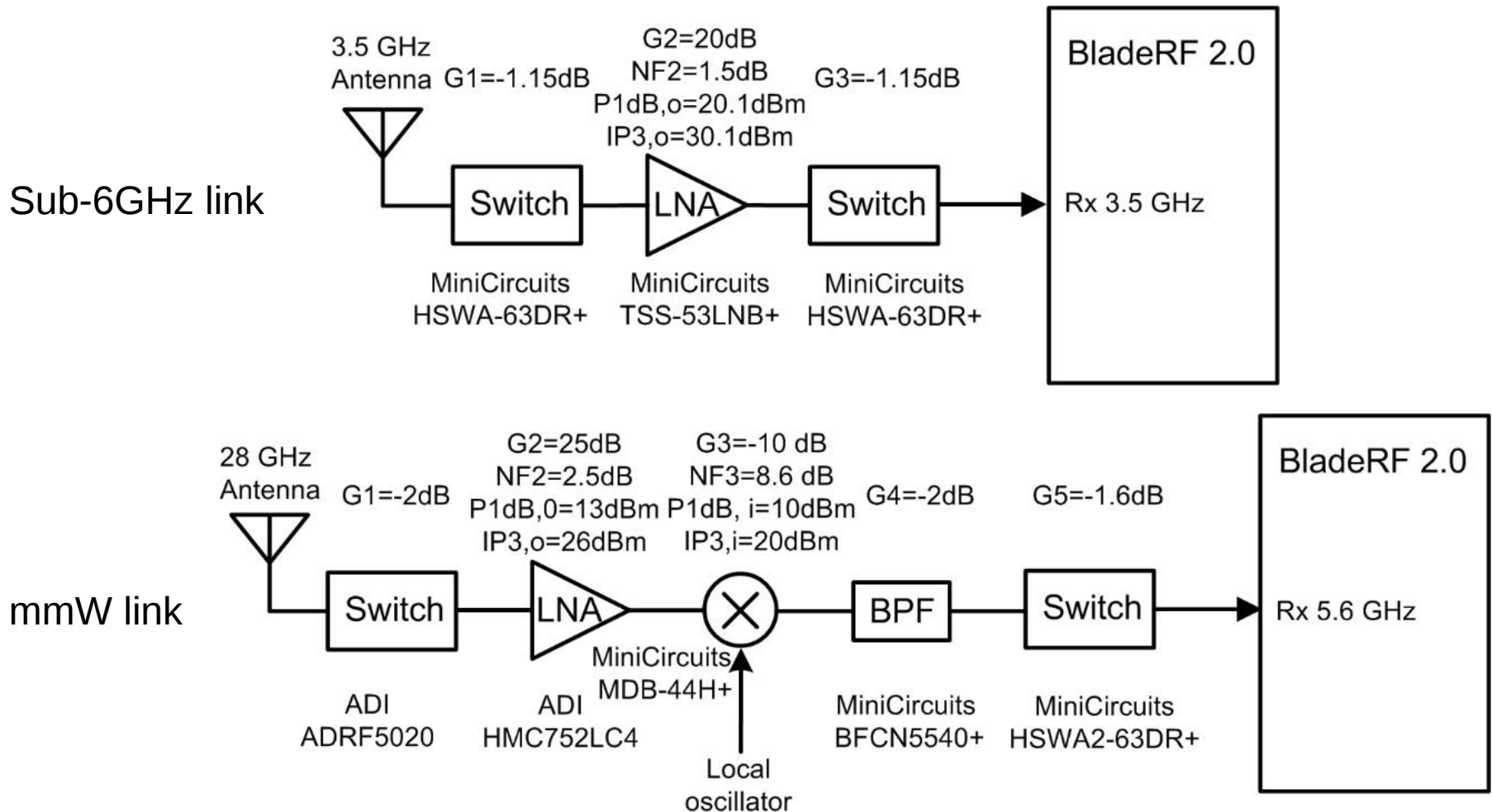
$$X_{total}^{\min} = \left(\sum_{n=1}^M \frac{1}{X_n G_n} \right)^{-1}$$

$$X_{total}^{\max} = \left(\sum_{n=1}^M \frac{1}{X_n^2 G_n^2} - 2 \sum_{\substack{n=2 \\ n>k}}^M \sum_{k=1}^M \frac{1}{X_n X_k G_n G_k} \right)^{-1/2}$$

Ref: N. G. Kanaglekar, R. E. McIntosh, and W. E. Bryant, "Analysis of two-tone, third-order distortion in cascaded two-ports," *IEEE Trans. Microw. Theory Techn.*, vol. MTT-36, pp. 701-705, Apr. 1988.



Sub-6GHz/mmW 共構之射頻接收機系統



- Performance evaluation by approximated formulas or CAD tool



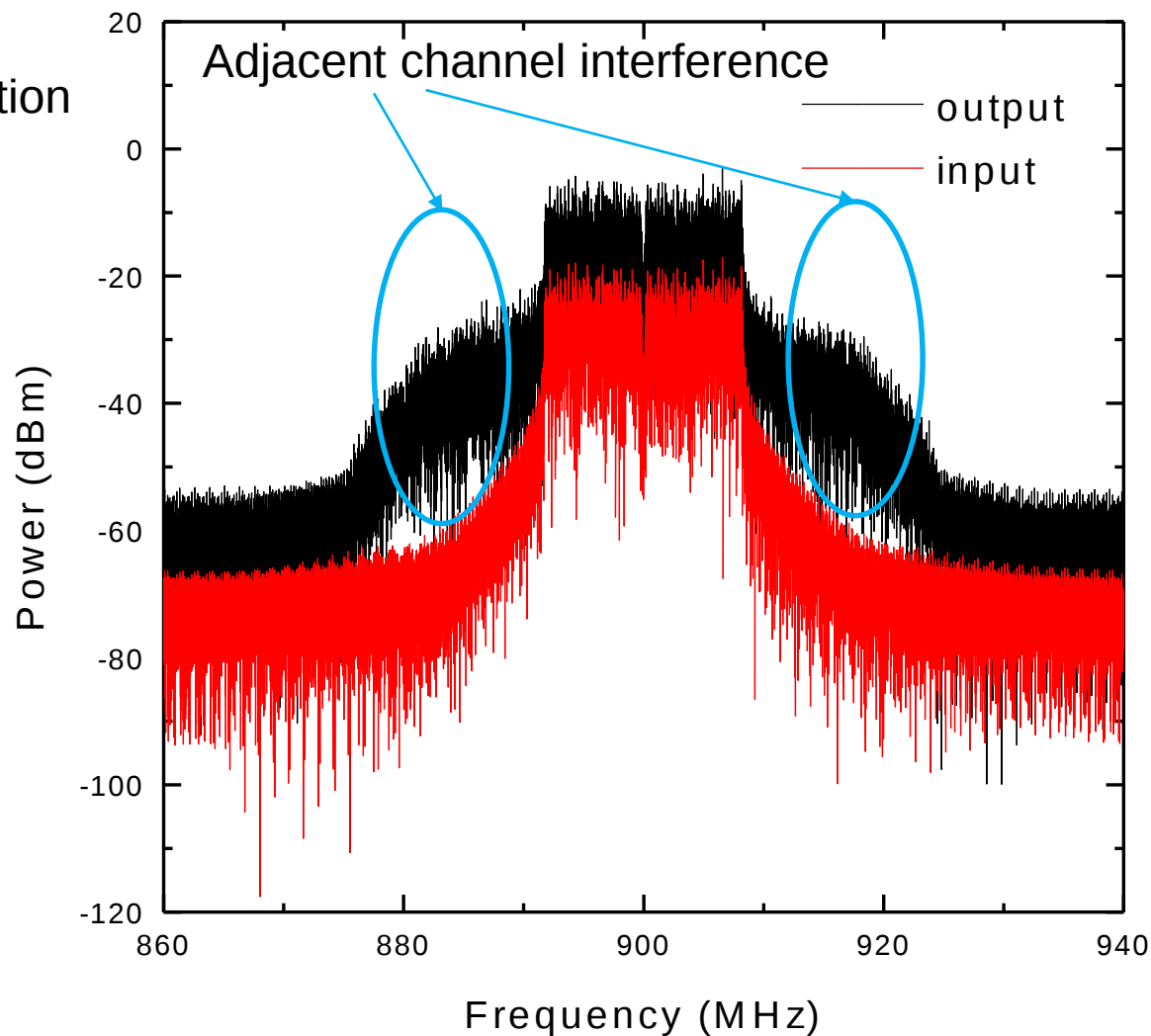
Sub-6GHz/mmW射頻發射機系統效能

- 發射機鏈路增益
- 發射機輸出1dB增益壓縮點、三階折斷點與輸出功率
- 發射機信號失真度
- 發射機輸出諧波與雜波

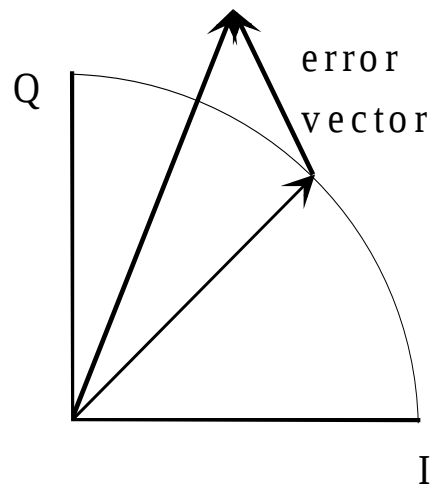
發射機輸出信號鄰頻干擾

Power amplifier
nonlinear distortion

OFDM/16QAM
modulation

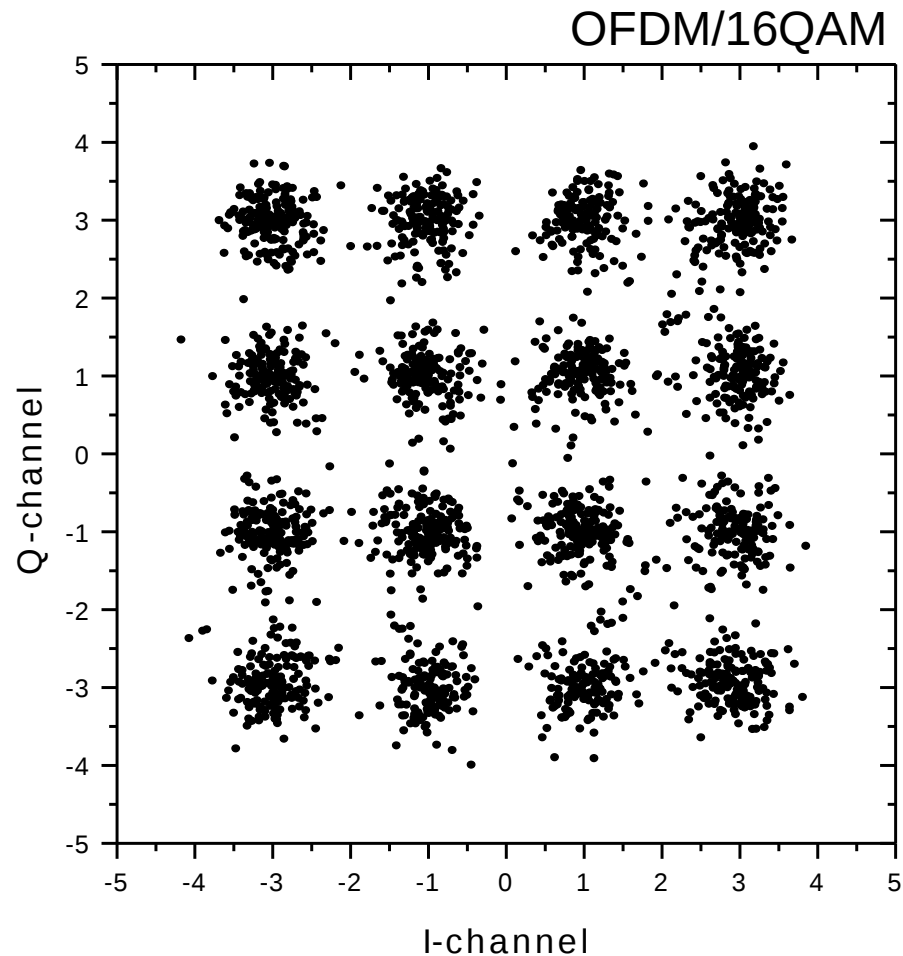


發射機輸出信號失真度

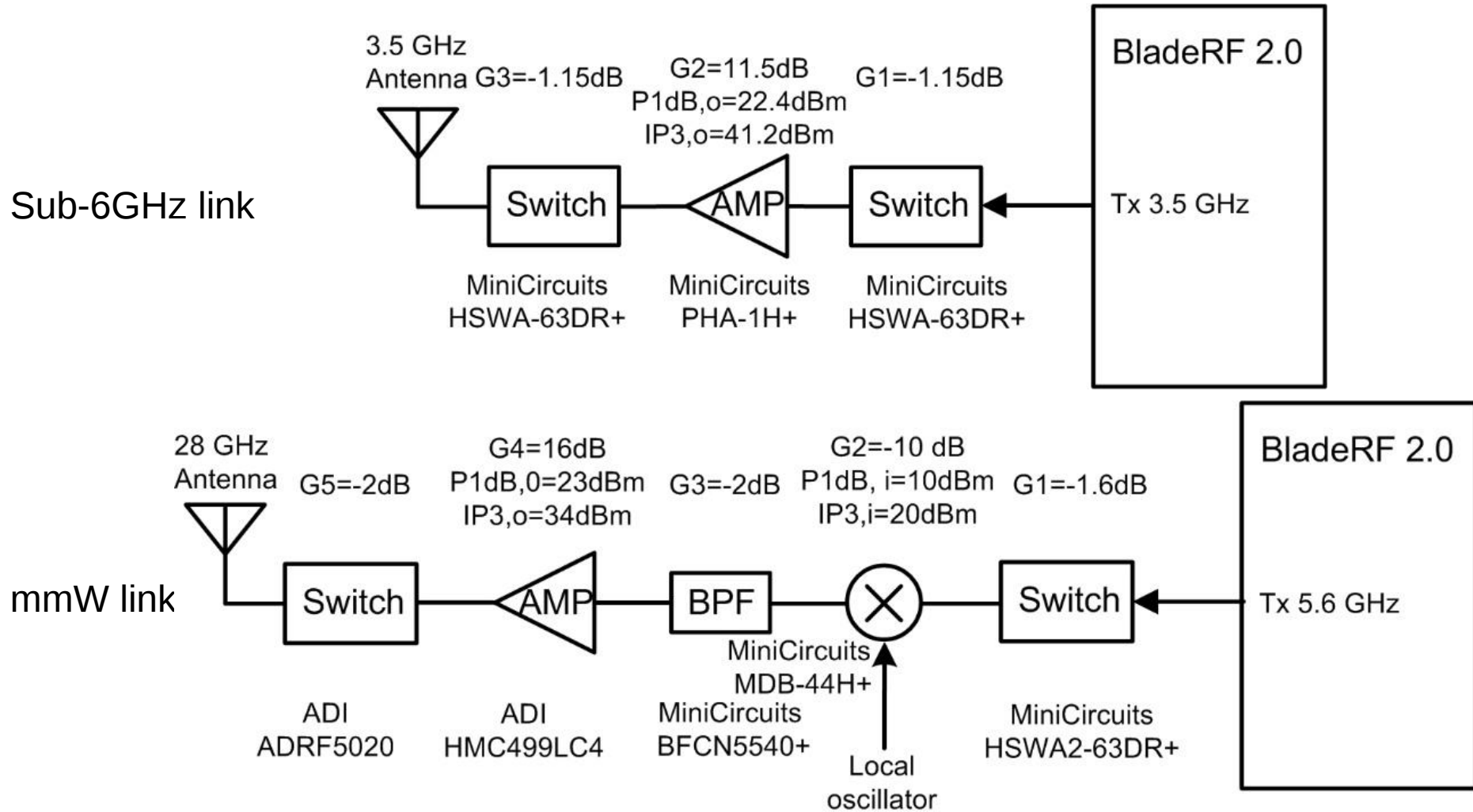


Error Vector Magnitude

$$EVM_{RMS} = \sqrt{\frac{\sum_{j=1}^{L_s} \left[\sum_{k=1}^{52} (C_k^{distorted} - C_k^{ideal})^2 \right]}{52 \times L_s \times P_0}}$$



Sub-6GHz/mmW 共構之射頻發射機系統



- Performance evaluation by approximated formulas or CAD tool



Sub-6GHz/mmW 多天線輸入輸出系統

- 目的

- 增加天線系統等效全向輻射功率
- 提升傳輸信號品質
- 增加資訊傳輸率

- 實現方式

- 平面式天線搭配嵌入式射頻模組
- 可調整每個天線信號的大小與相角
- 可執行不同功能
 - ✓ 傳輸分集 (Transmit diversity)
 - ✓ 空間複用 (Spatial multiplexing)
 - ✓ 波束成型 (Beamforming)

波束成型－相位陣列天線輻射場型關係

- 陣列天線輻射場型可表為天線元件因子（antenna element factor）乘以陣列因子（array factor）

$$F(\theta, \varphi) = F_{array}(\theta, \varphi) \cdot F_{element}(\theta, \varphi)$$

- 若陣列天線為排列在z-軸等間距 d 的 $2N+1$ 個線性陣列

$$F_{array}(\theta) = \sum_{n=-N}^N I_n e^{jkn d \cos \theta}, \quad k = \omega \sqrt{\mu_0 \epsilon_0},$$

- 若饋入天線之電流大小相同、相移為等差相位

$$I_n = I_0 e^{-jn\alpha_z}, \quad F_{array}(\theta) = \sum_{n=-N}^N e^{jn(kd \cos \theta - \alpha_z)}$$

- 調整 α_z 即可調整主波瓣輻射角度 θ_0

$$kd \cos \theta_0 = \alpha_z, \quad \theta_0 = \cos^{-1} \left(\frac{\alpha_z \lambda}{2\pi d} \right)$$

相位陣列天線輻射場型實際狀況

- 陣列因子較易計算掌控
- 陣列天線整體輻射場型須包含天線元件因子，天線指向性越高，對整體場型影響越大
- 天線間之耦合效應亦會造成整體輻射場型變異
- 陣列天線之振幅調整（可調增益放大器或衰減器）以及相移器相移誤差造成陣列因子偏移
- 振幅調整會造成額外相移，相移調整也會造成各額外損耗，皆影響陣列因子結果

Sub-6GHz/mmW 多天線輸入輸出系統效能

- 波束成型效能
 - 可掃描最大角度
 - 主波瓣掃描最大角度時，主波瓣波束寬度變化量
 - 主波瓣掃描最大角度時，旁波瓣變化量

各種波束成型設計架構 - I

- 射頻端相移
- 本地振盪端相移
- 中頻／基頻端類比式相移
- 數位式相移
- 混合波束成型架構

波束掃描對射頻傳收機系統效能影響

- 不同相位移時，可能造成射頻鏈路衰減量不同
- 接收雜訊指數可能在不同相位移時產生不同值
- 發射功率可能在不同相位移時產生不同結果
- 發射信號失真度可能在不同相位移時有不同失真量
- 數位式相移對射頻傳收機效能影響量最低

Sub-6GHz/mmW共構之 多輸入輸出射頻模組— 與天線陣列之整合技術

大綱

- 半導體封裝與印刷電路板整合技術概觀
- 應用封裝與印刷電路板製程於天線陣列設計
- 應用封裝與印刷電路板製程於天線陣列與射頻模組整合
- 電源完整性、信號完整性、電磁干擾與散熱問題

半導體封裝技術概觀

- Embedded Wafer-Level Ball grid array (eWLB)
- Redistributed Chip Package (RCP)
- Integrated Fan-out Wafer Level Package (InFO-WLP)
- Embedded Wafer Level Package-on-Package (eWLB-PoP)

射頻模組與天線陣列整合設計

- 射頻模組與天線陣列高密度整合下之設計挑戰
 - 高密度整合下電源分配網路之電源完整性問題
 - 高密度整合下類比/數位信號傳輸之信號完整性問題
 - 高密度整合之電磁干擾問題
 - 高密度整合之散熱與可靠度問題
- 可用之分析模擬技術
 - 電路/電磁/天線整合模擬分析技術
 - 熱/電/應力之多重物理模擬分析技術